Notice of References Cite
---------------------------

Application/Control No.	Applicant(s)/Pate	nt Under	
10/814,572	Reexamination MITCHELL ET AL.		
Examiner	Art Unit		
HABTE MERED	2474	Page 1 of 3	

### U.S. PATENT DOCUMENTS

	C.S. FATERI DOCUMENTS								
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification				
*	Α	US-2004/0105390	06-2004	Saksio, Mauri	370/245				
*	В	US-6,222,820	04-2001	Hamami, Ilan	370/218				
*	С	US-6,738,345	05-2004	Williamson, H. Keith	370/217				
*	D	US-2002/0186654	12-2002	Tornar, Massimiliano	370/225				
*	Е	US-6,229,787	05-2001	Byrne, Donal M.	370/218				
*	F	US-2007/0159971	07-2007	Zhang et al.	370/230				
*	G	US-6,535,491	03-2003	Gai et al.	370/256				
*	н	US-7,127,633	10-2006	Olson et al.	714/4				
*	_	US-2002/0188711	12-2002	Meyer et al.	709/223				
*	J	US-2007/0159971	07-2007	Zhang et al.	370/230				
*	к	US-2002/0186654	12-2002	Tornar, Massimiliano	370/225				
*	L	US-5,959,972	09-1999	Hamami, Ilan	370/228				
*	М	US-6,195,351	02-2001	Hiscock et al.	370/389				

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

### NON-PATENT DOCUMENTS

# \* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V X

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited
----------------------------

Application/Control No.	Applicant(s)/Pate	nt Under	
10/814,572	Reexamination MITCHELL ET AL.		
Examiner	Art Unit		
HARTE MERED	2474	Page 2 of 3	

### U.S. PATENT DOCUMENTS

	C.C. TATENT BOOMENTO								
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification				
*	Α	US-6,728,780	04-2004	Hebert, James E.	709/239				
*	В	US-2002/0016874	02-2002	Watanuki et al.	710/51				
*	С	US-2005/0058063	03-2005	Masuyama et al.	370/217				
*	D	US-7,188,189	03-2007	Karol et al.	709/238				
*	Е	US-7,818,628	10-2010	Bishara, Nafea	714/43				
*	F	US-2007/0154219	07-2007	Feinberg, Lee Daniel	398/104				
*	G	US-6,981,174	12-2005	Hanning, Gary	714/5.1				
*	Н	US-7,152,178	12-2006	Vook et al.	714/4.3				
*	_	US-6,285,656	09-2001	Chaganty et al.	370/228				
*	J	US-2002/0152320	10-2002	Lau, Pui Lun	709/238				
	к	US-							
	L	US-							
	м	US-							

### FOREIGN PATENT DOCUMENTS

	TOTAL TALETT BOODINGTO									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification				
	N									
	0									
	Р									
	Q									
	R									
	s									
	т									

# NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
	U							
	v							
	w							
	x							

'A copy of this reference is not being turnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/814,572	Applicant(s)/Patent Under Reexamination MITCHELL ET AL.	
Notice of helefelices Cited	Examiner	Art Unit	
	HABTE MERED	2474	Page 3 of 3

15	P	Δ٦	F	JT	DO	CI	ш	FN	TS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification				
	А	US-							
	В	US-							
	С	US-							
	D	US-							
	Е	US-							
	F	US-							
	G	US-		-					
	Н	US-							
	T	US-							
	J	US-							
	к	US-							
	L	US-							
	М	US-							
	FOREIGN PATENT DOCUMENTS								

TOTAL AT LATE OF COMMENTS							
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	s						
	т						

# NON PATENT DOCUMENTS

NON-PATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	v						
	w						
	х						

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.